

Mass test setup for the DUNE FD1 SiPMs characterization and first results

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Università
degli Studi
di Ferrara



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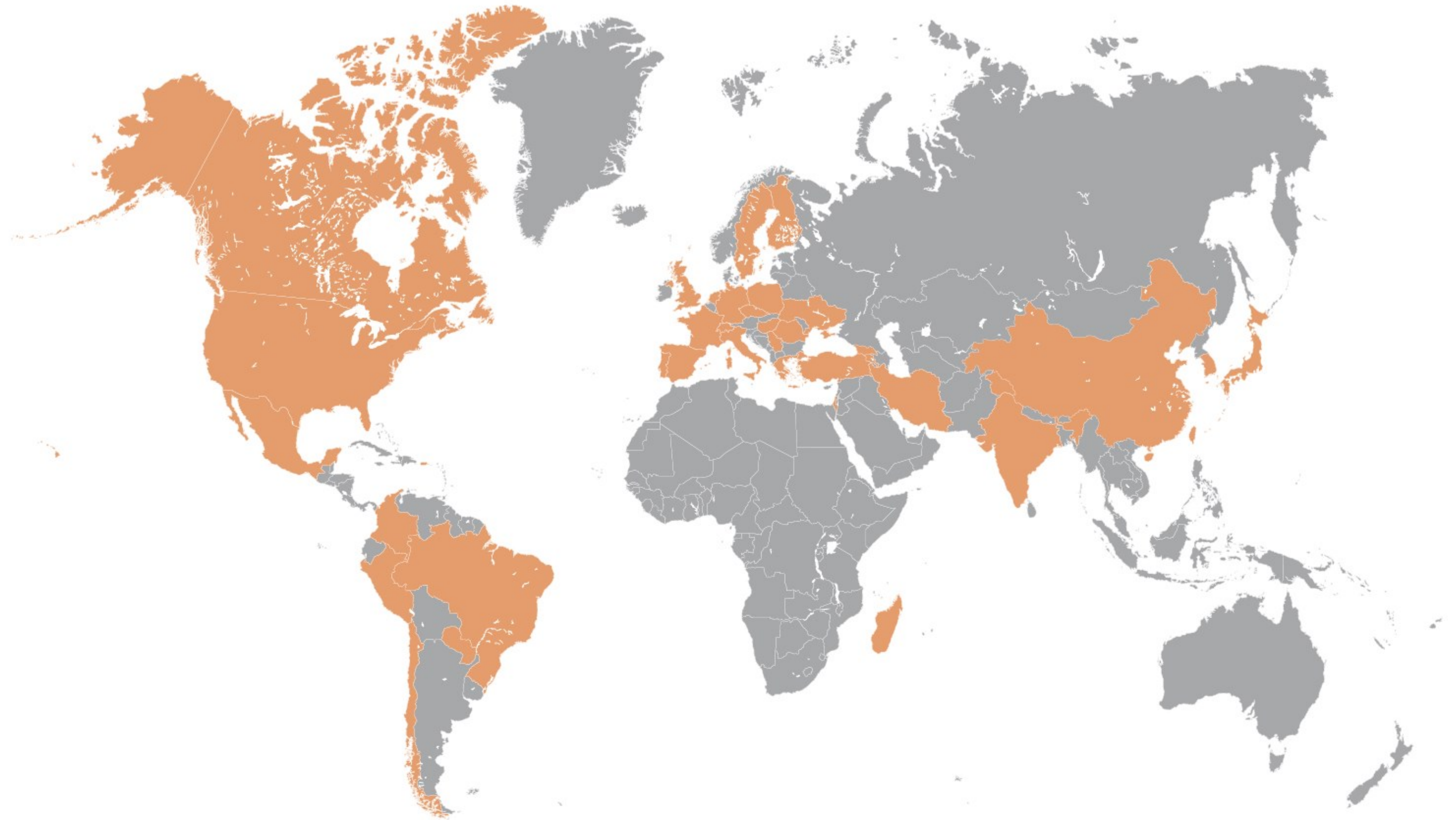
- Overview of the DUNE experiment
- ProtoDUNE & DUNE FAR detector:
 - SiPMs in the Photon Detection System
- CACTUS: the quality assurance test setup
 - Features
 - Procedure
 - Tests
- Characterization Results of the first production lot
- Conclusions

The DUNE Collaboration

- More than 1440 collaborators;
- 37 countries;
- 208 institutions including CERN.



DUNE Collaboration meeting
FNAL May 2023



Deep Underground Neutrino Experiment (DUNE)

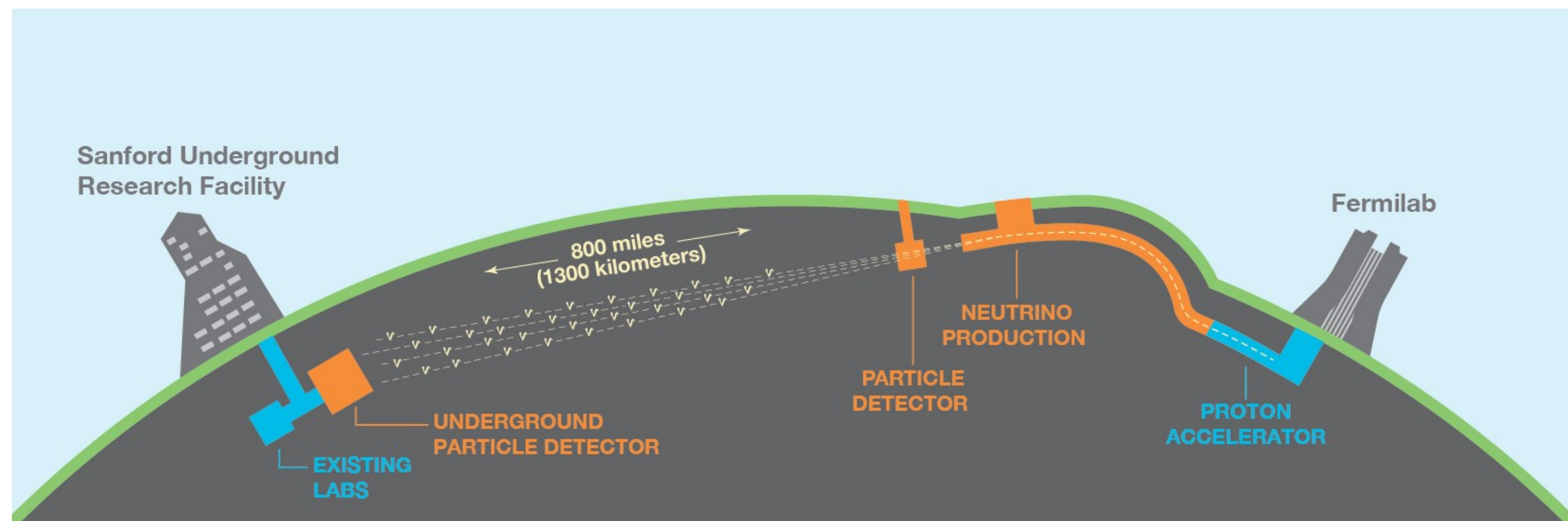
DUNE, main physics goals:

- Precise measurement of neutrino oscillation parameters (mass ordering and δ_{CP});
- Study supernova low energy neutrino;
- Physics beyond SM;

EPJC 80 (2020) 978

EPJC 81 (2021) 322

EPJC 801(2021) 423



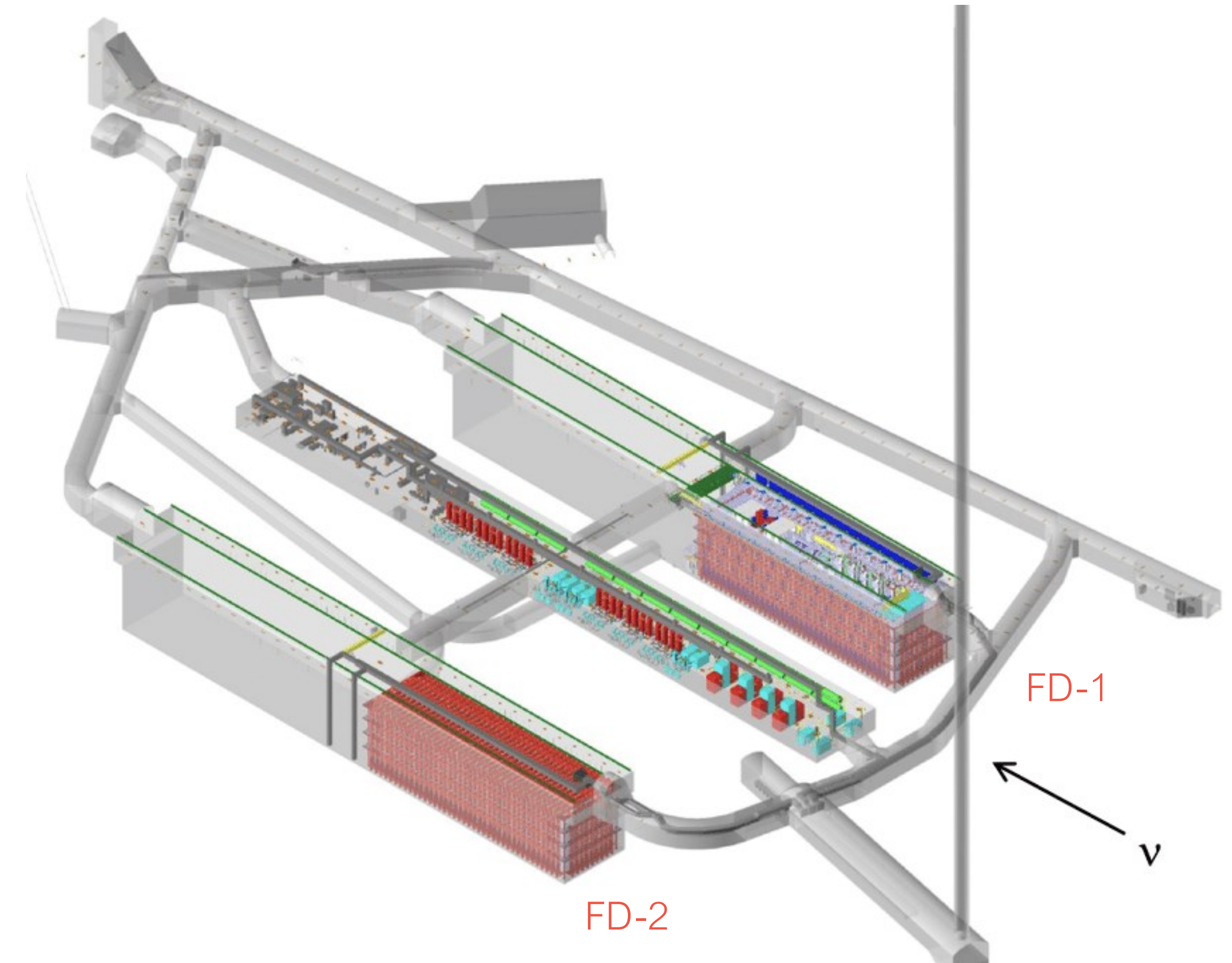
- New neutrino **beam facility @ FNAL (LBNF)**
- **Near detectors @ FNAL** → measure unoscillated neutrino spectrum & flux constraints
- **Far detectors @SURF** → oscillated neutrino studies

JINST 15 (2020) T08008

JINST 15 (2020) T08010

DUNE Far Detector

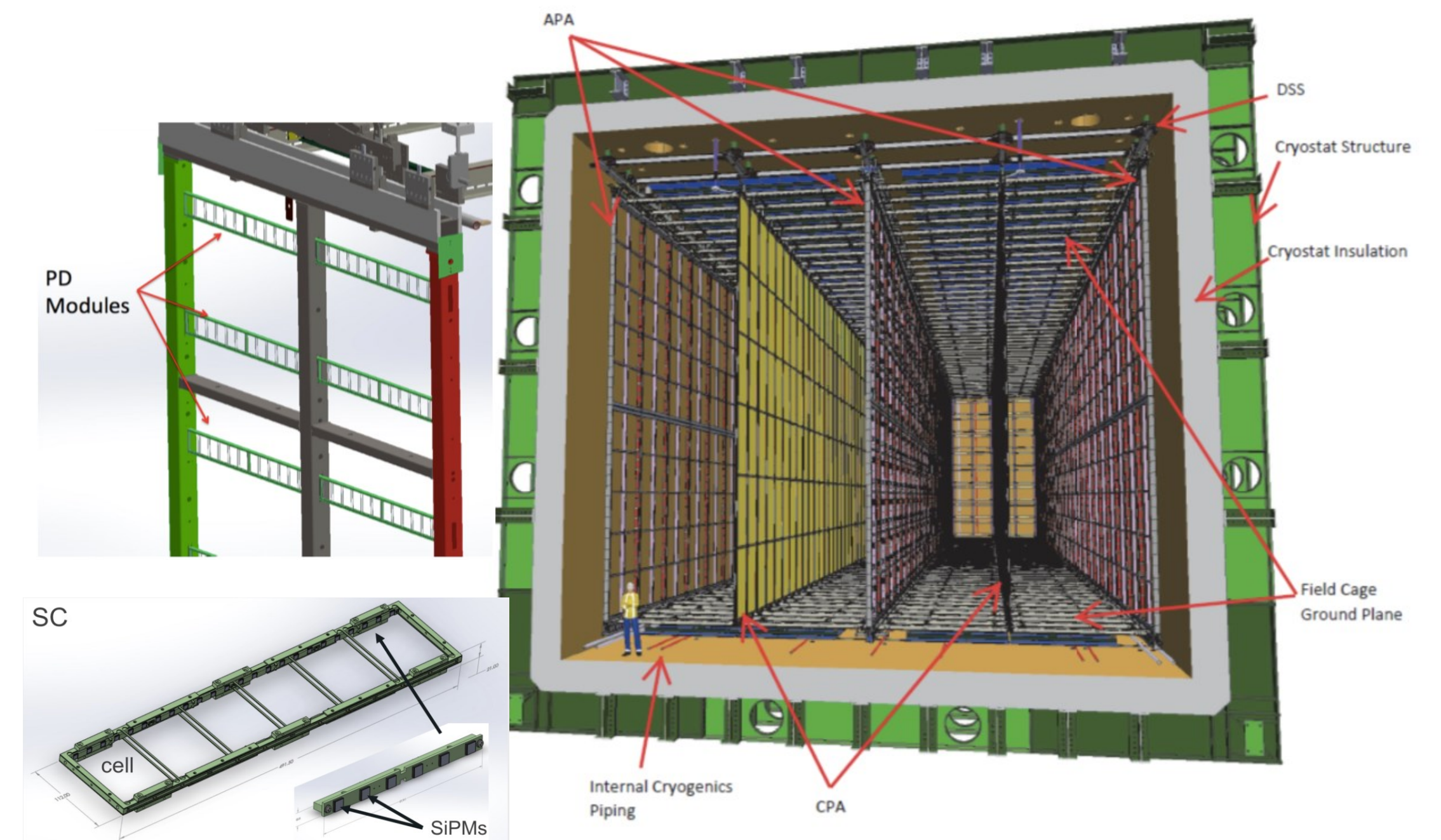
- Located ~1300km from the production site ~1.48 km underground @ Sanford Underground Research Facility in Lead, South Dakota (USA)
- Four 17-kt LAr TPC modules
- Phase I:
 - **FD-1 horizontal drift (HD)**
 - FD-2 vertical drift (VD)
- ProtoDUNEs
 - Construction and operation of 1 kton-scale prototypes at CERN, critical to demonstrate viability of technology



FD-1 HD

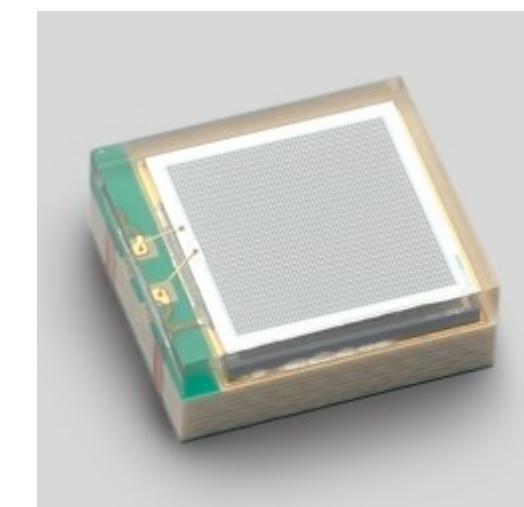
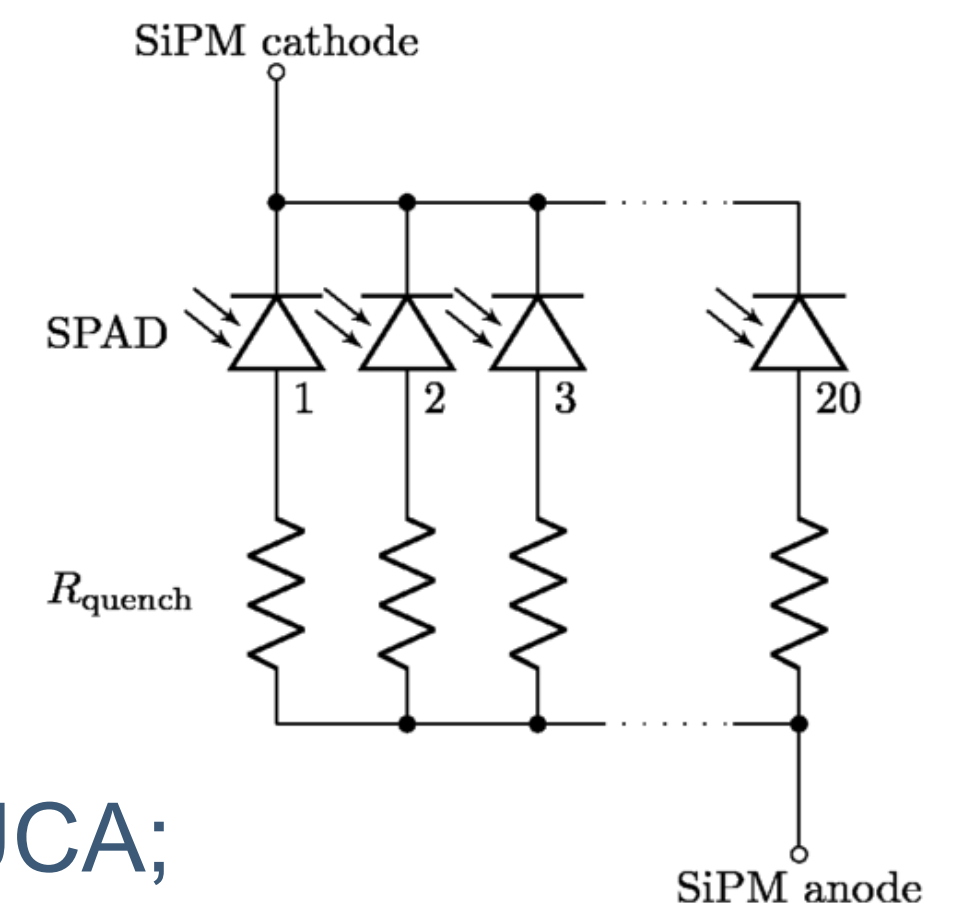
- 4 drift volumes. Anode-cathode drift distance 3.5 m with $E = 500$ V/cm.
- 150 Anode Plane Assemblies (APAs).
Each APA consists of three wire planes for charge collection and 10 Photon Detection modules.
- 10 (2m x 12cm) PD modules/APA
each composed by 4 X-ARAPUCA supercells.
- A supercell consists of
six 10×10 cm² pTP-coated dichroic filters,
a 60 cm WLS bar and 48 SiPMs.
- ~300k SiPMs in total.

*see "DUNE Photon Detection System" presentation
by Gabriel Botogoske!*



The DUNE photosensors

- SiPMs
 - A matrix of single-photon avalanche photodiodes operating in reverse bias above breakdown voltage V_{bd} ;
 - Robust, high sensitivity and dynamic range, immune to B field, reduced cost/size;
- Specifications for DUNE:
 - Quantum efficiency $> 35\%$ for 430 nm light @ 87 K;
 - Dimensions compatible w/ ARAPUCA design;
 - SiPM + FEE w/ dynamic range 1-2000 photons, even for events far from the ARAPUCA;
 - Dark count Rate (DCR) subdominant wrt noise from ^{39}Ar ($< 200\text{mHz/mm}^2$);
 - Cross-talk (CT) $< 35\%$ and after-pulse (AP) $< 5\%$;
 - Durability (> 10 y) and cryoreliability (resistant to multiple cool-downs);
 - 200-100ns recovery time.



JINSTRUM 19.01 (2024): T01007

The DUNE photosensors

- **SiPMs:**

- Several models tested from two vendors: HPK, FBK; ~50% of FD-1 SiPMs each;
- Chosen models **HPK S16517** (6x6mm², 75um pitch) & **FBK NUV-HD-CryoTT** (6x6mm², 33um pitch);
- Mounted in arrays with 6 SiPMs each in common cathode configuration w/ independent anode;



- ~100 SiPMs during selection process;
- ~8k SiPM for ProtoDUNE-HD tested in 2022;
- ~300k SiPM for DUNE FD-1 under test (2023 – ...).

- **Measurements to be performed:**

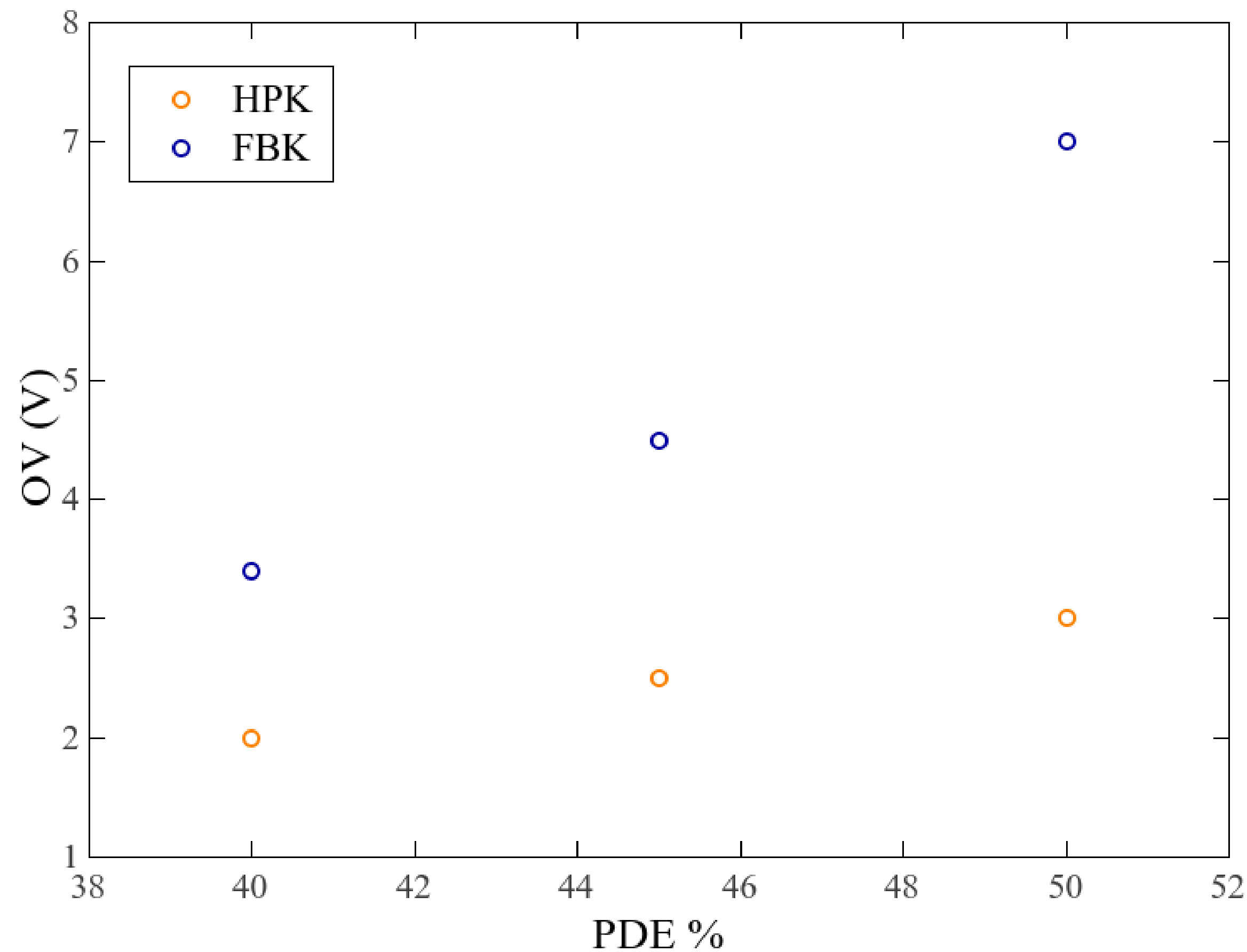
- IV curves in FWD and REV bias @ room temperature and LN2 temperature;
- Thermal stresses resilience;
- DCR @ LN2 temperature.



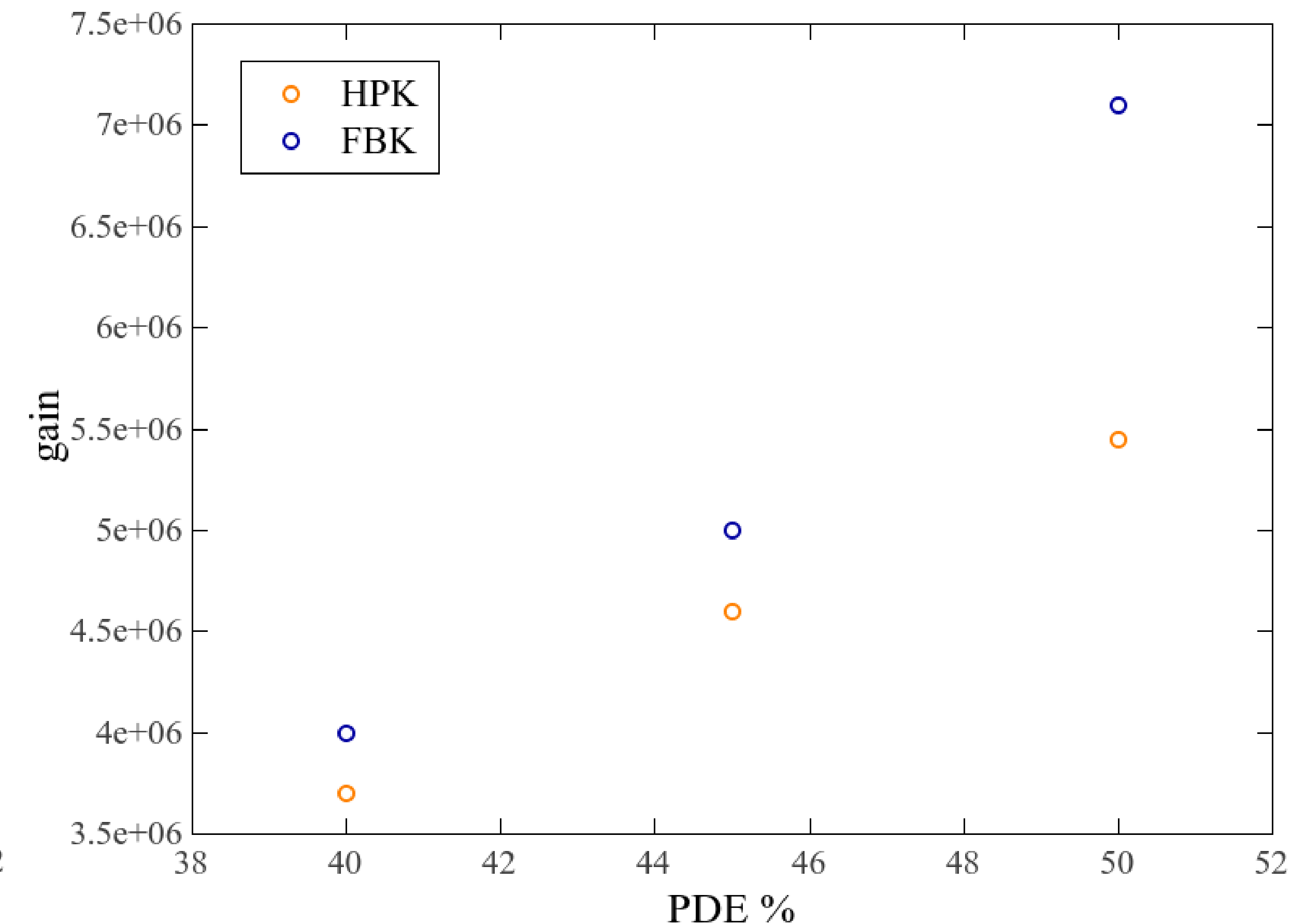
HPK tray example

The DUNE photosensors

- Operating voltage VS PDE



- Gain VS PDE



The Quality Assurance Test Setup

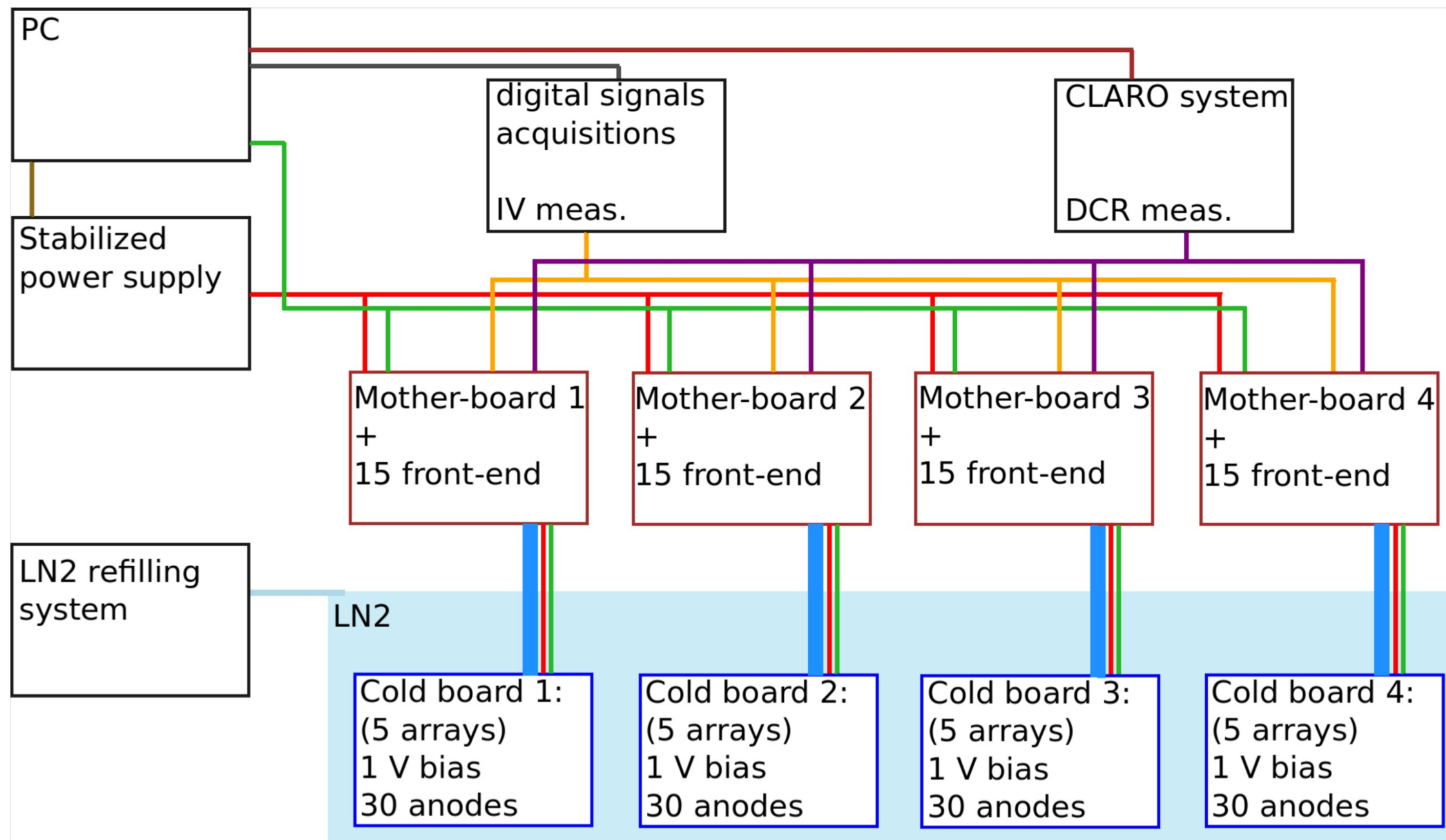


- Custom setup developed by INFN and Universities of Ferrara and Bologna;
- Massive tests on the entire FD-1 SiPMs production to assess:
 - SiPM identity;
 - Failure/mortality rate;
 - Quality assurance;
- Capability: test of 120 SiPM (20 arrays) in a single session of complete characterization (lasting < 6 h);
- 5 different test sites: Bologna, Ferrara, Granada, Milano Bicocca and Prague;
 - Test rate ≥ 2400 SiPM/month @ each site

The Quality Assurance Test Setup



Scheme of the setup, featuring modularity, automation, easy replication



Features:

- 55 liters liquid Nitrogen auto refilling system;
- 120 parallel channels;
- Voltage range [-210;210]V;
- Voltage precision 10mV;
- DC acquisition mode;
- Measured current in range 10nA-3mA;
- AC acquisition mode;
- Programmable threshold DCR from 30ke to 16Me;
- 60cm long translator stage.

The Quality Assurance Test Setup



- **Motherboards + front-end cards (@ warm):**

- 4 motherboards/system;
- 15 front-end cards/motherboard;
- 120 independent channels;
- Current measure/digitalization;
- Signals acquisition.



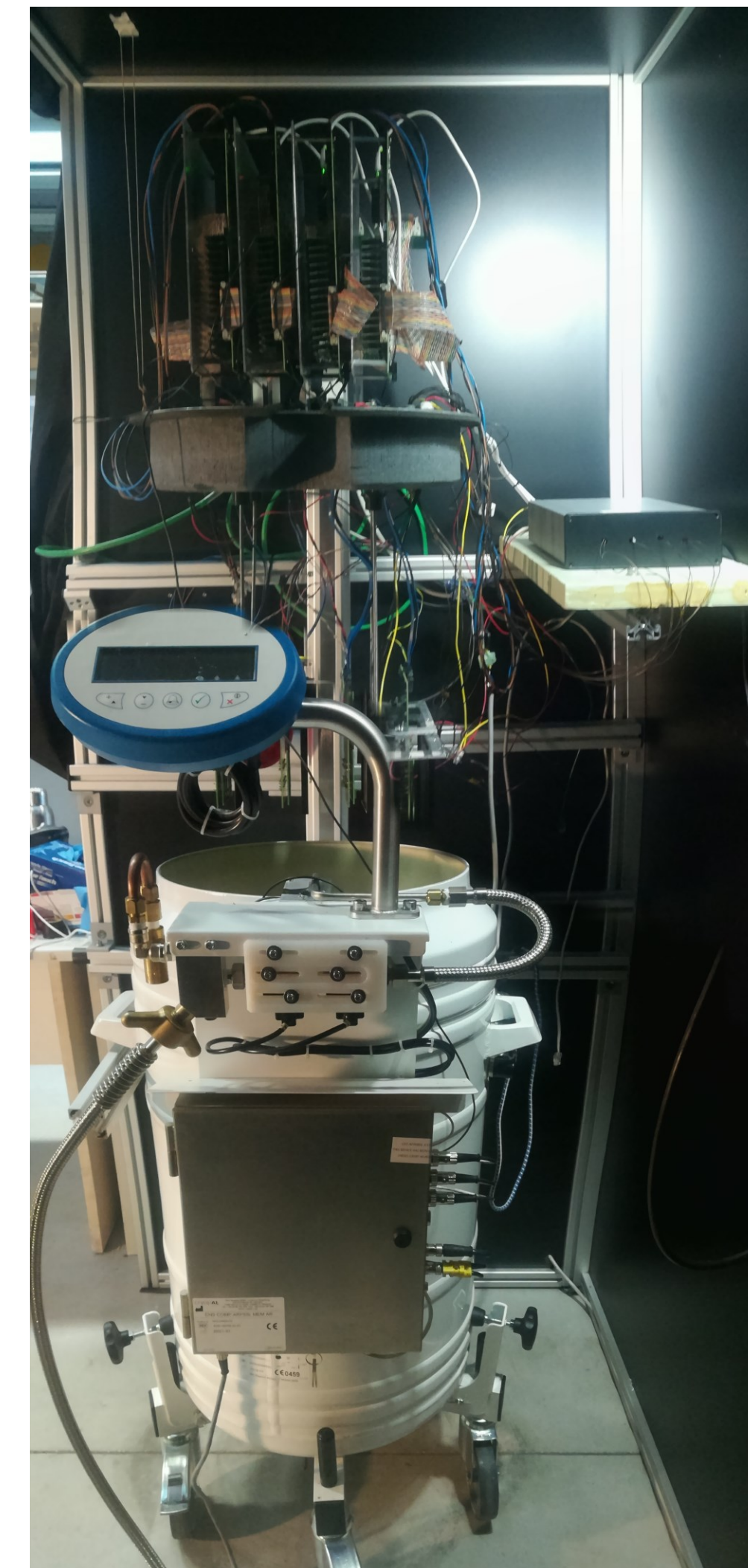
Motherboards + front-end

- **Cold boards (@LN2):**

- 4 boards;
- 5 arrays/board;
- 120 SiPM;
- Temperature monitor;
- Bias voltage.



Cold boards



Ferrara system

- **Python software** for run-time acquisition and analysis

Quality assurance procedure

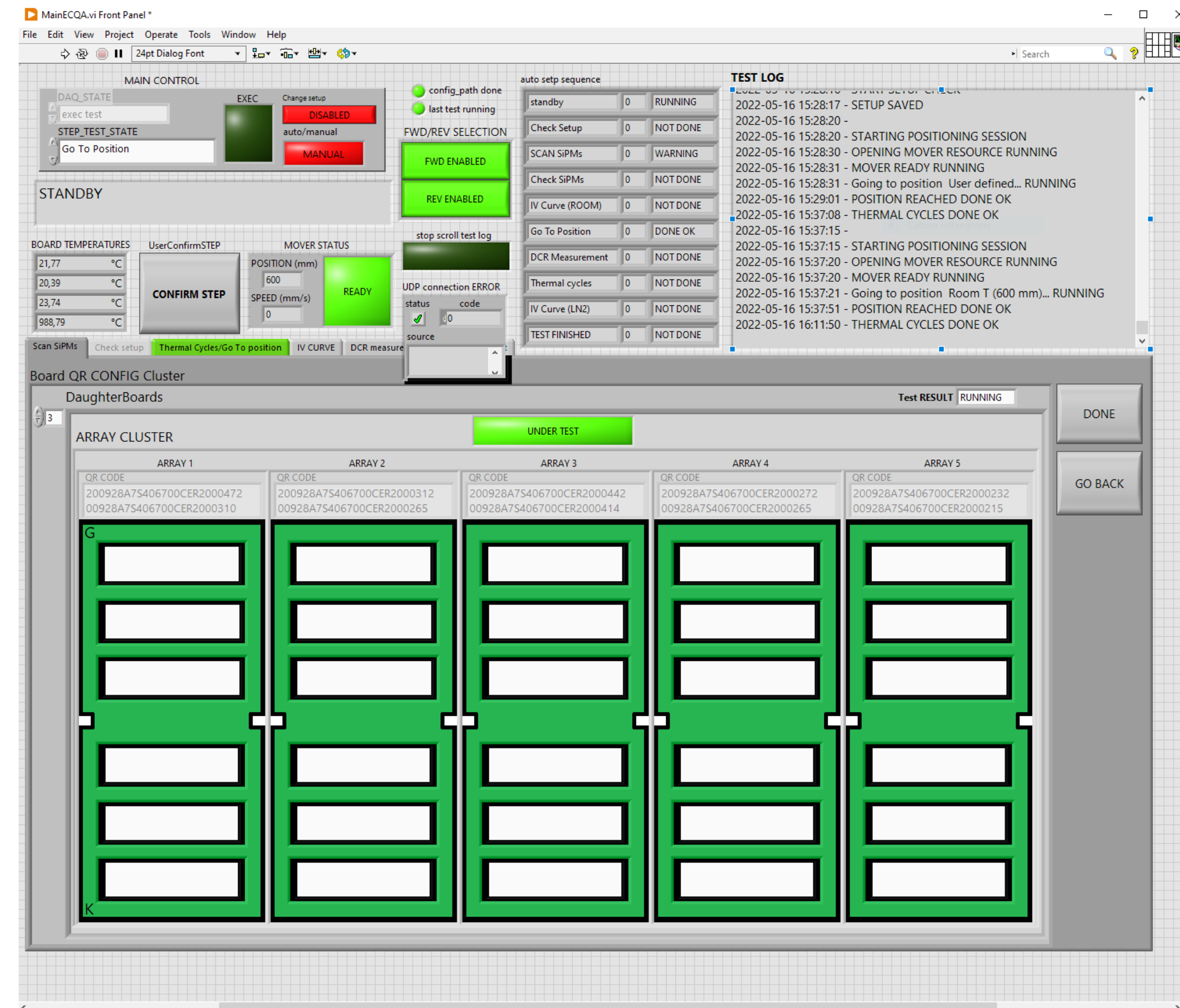


Unique Labview interface → perform each step of the QA tests

A panel shows the final report and if the SiPMs are in specs

Steps protocol & parameters:

- IV@roomT (10min) → (FW) R_q^{RT} + (REV) V_{bd}^{RT} ;
- First LN2 immersion (20min);
- IV@LN2T (10min) → (FW) $R_q^{LN2T_pre}$ + (REV) $V_{bd}^{LN2T_pre}$;
- 2 thermal cycles (1.5h);
- IV@LN2T (10min) → (FW) $R_q^{LN2T_post}$ + (REV) $V_{bd}^{LN2T_post}$;
- Extended IV@LN2T (10min) → dark current
- DCR@LN2 T (5min) → **global-DCR** total dark signals, AP, CT + bursts;



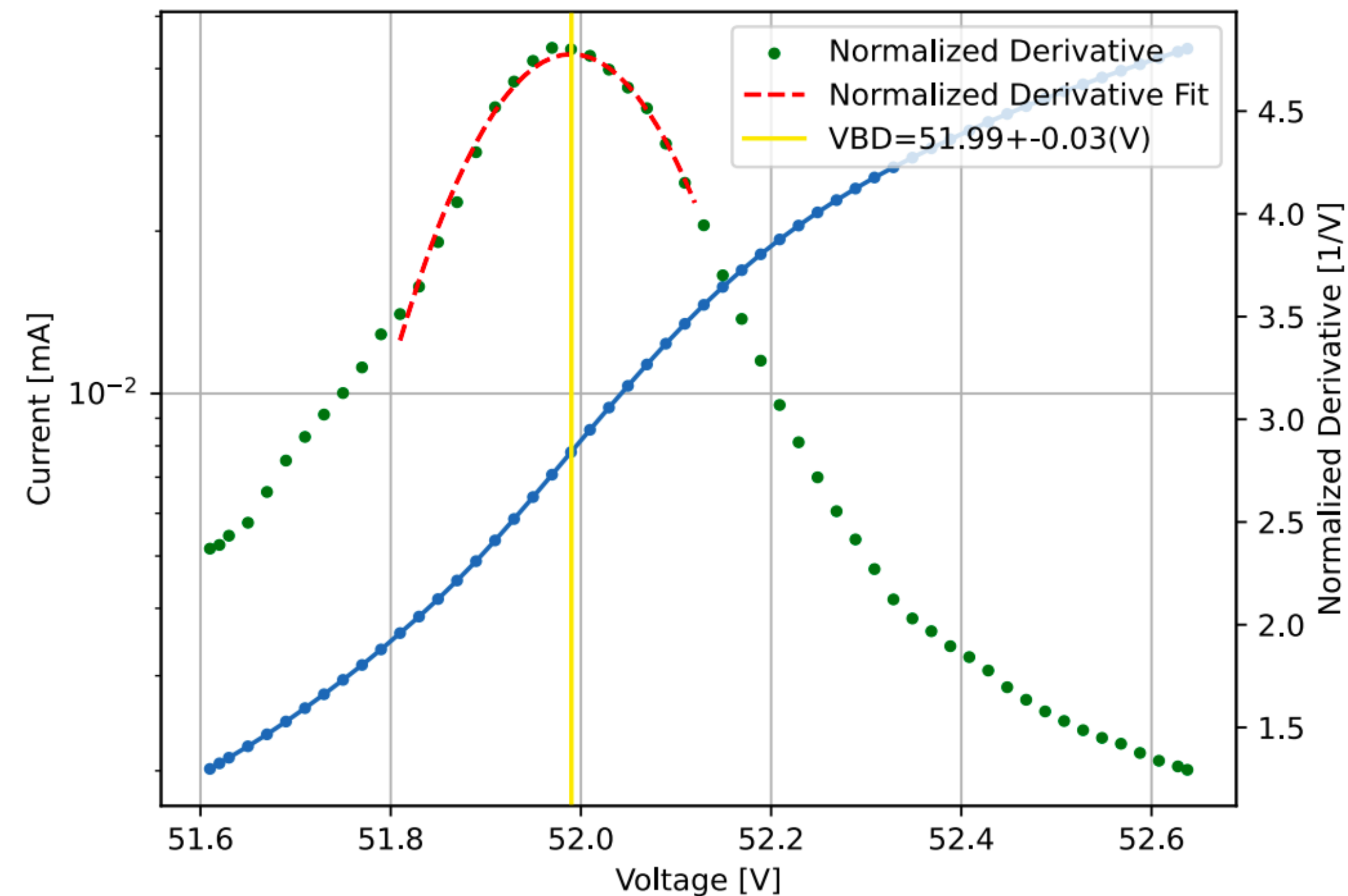
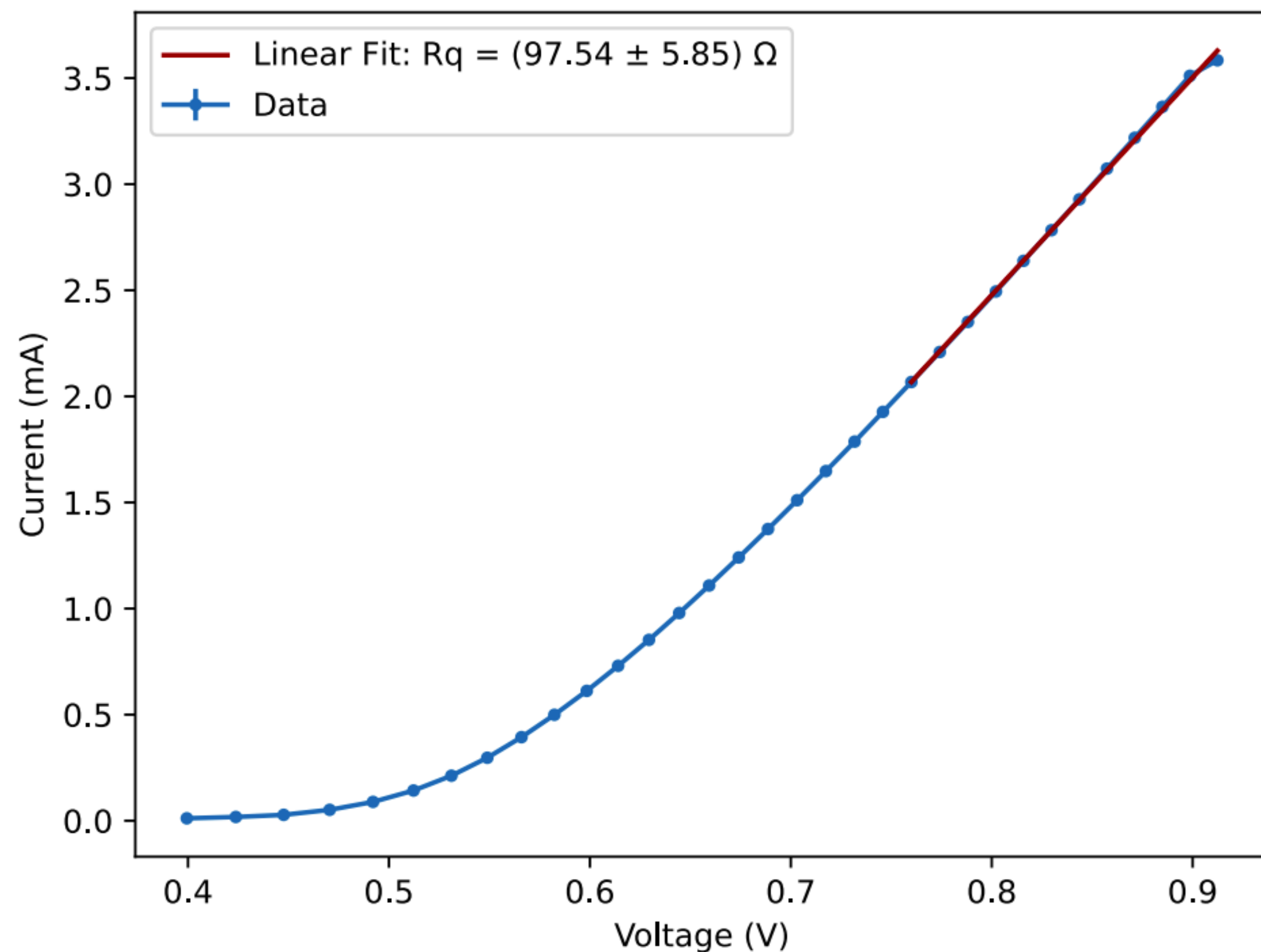
Labview interface

Single measurements examples



- Room temperature IV:

	Voltage range (V)	Current range	Step (mV)	Fit
Forward curve	0-1	[0.1-3.5]mA	20	Linear
Reverse curve	51-53	[10-500]nA	15	parabolic

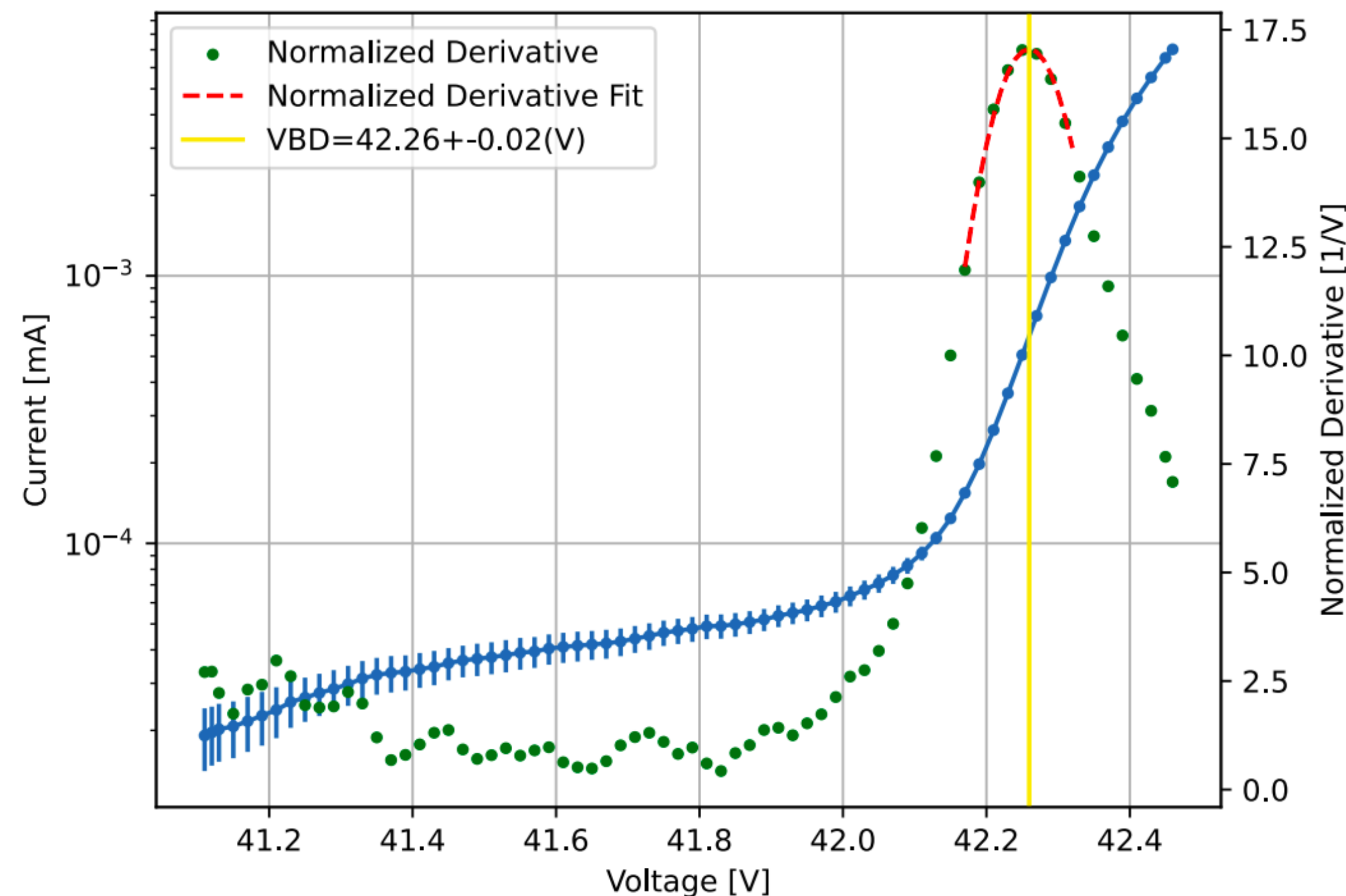
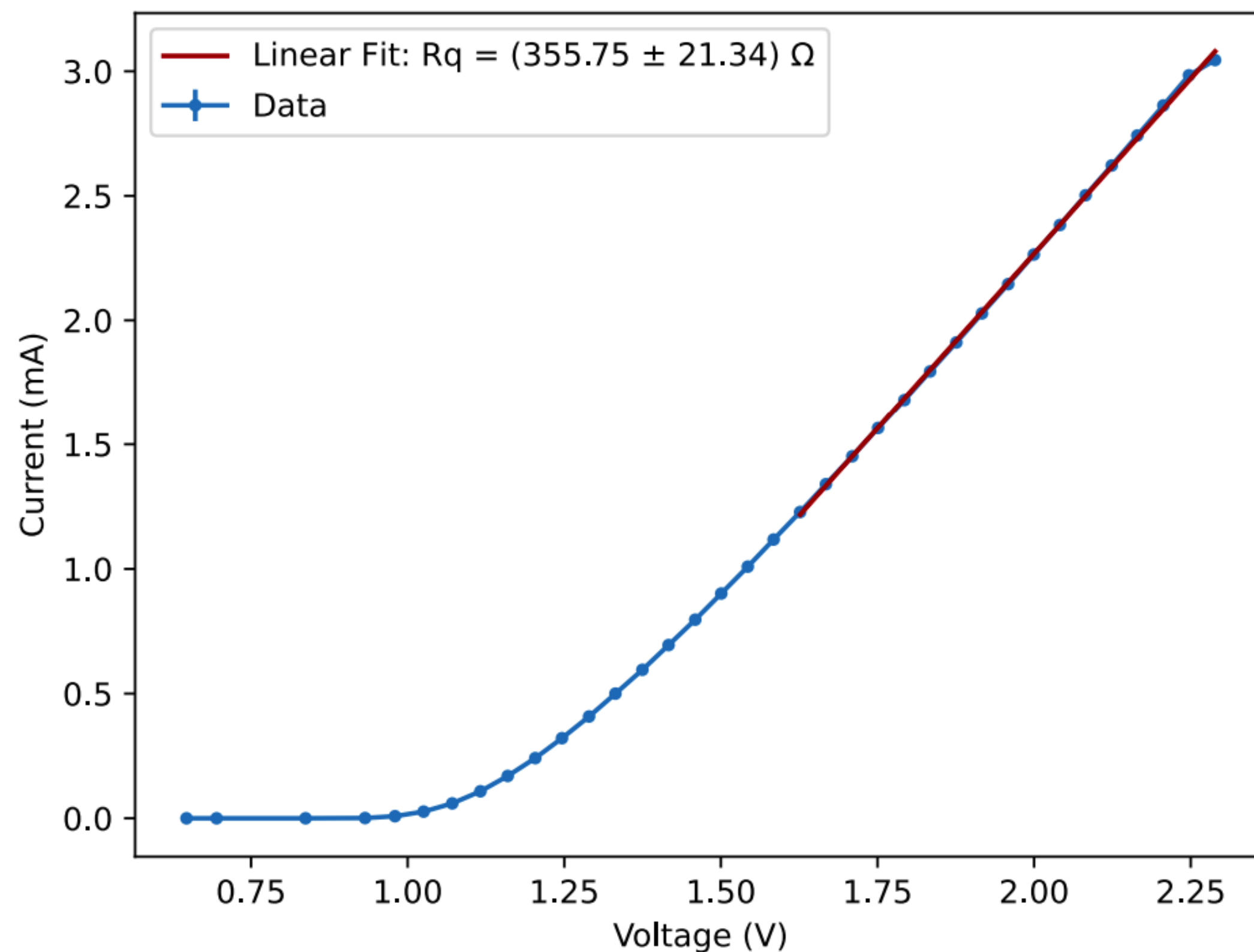


Single measurements examples

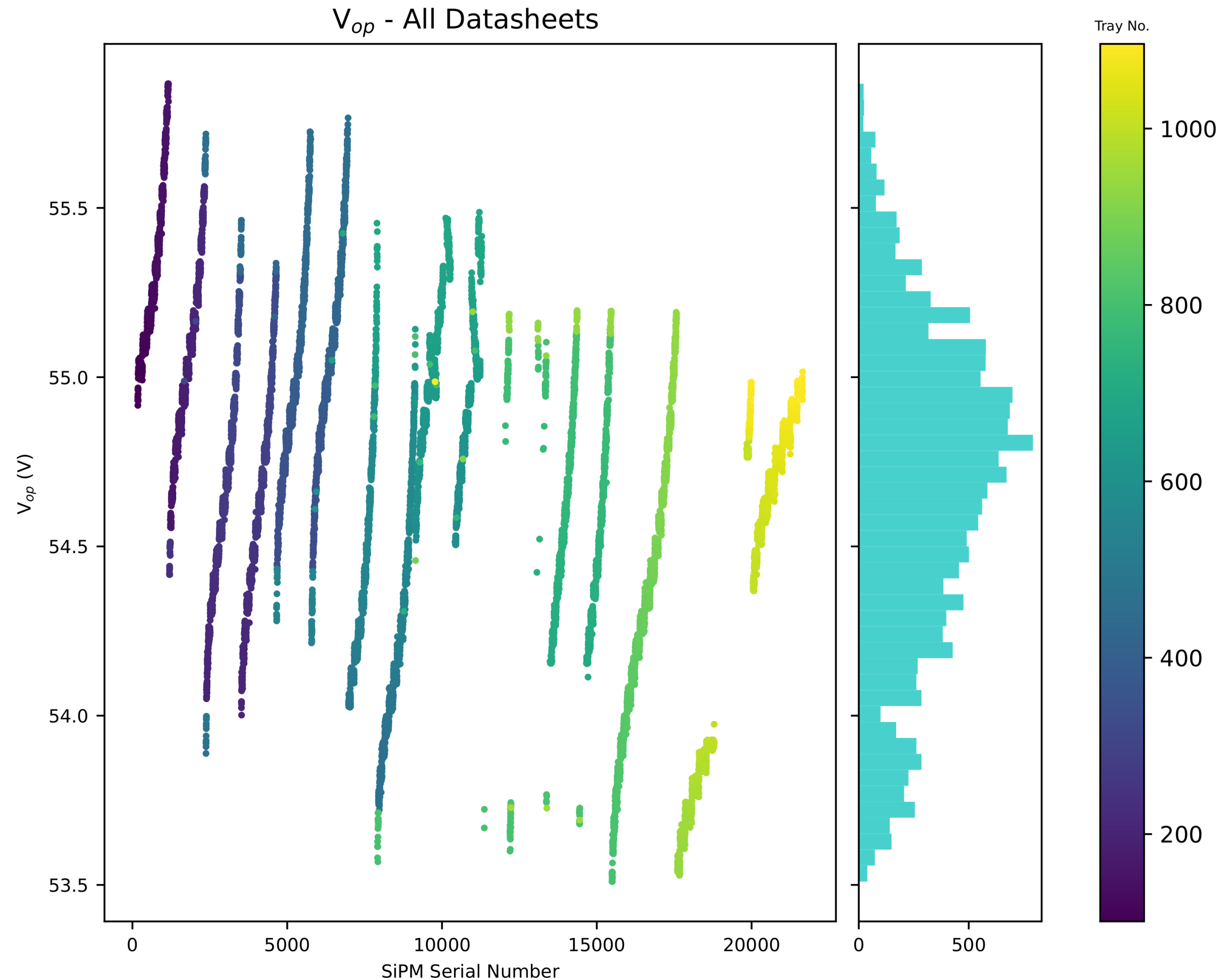


- LN2 temperature IV:

	Voltage range (V)	Current range	Step (mV)	Fit
Forward curve	0-2,3	[0.1-3.5]mA	20	Linear
Reverse curve	41-43	[10-500]nA	15	parabolic

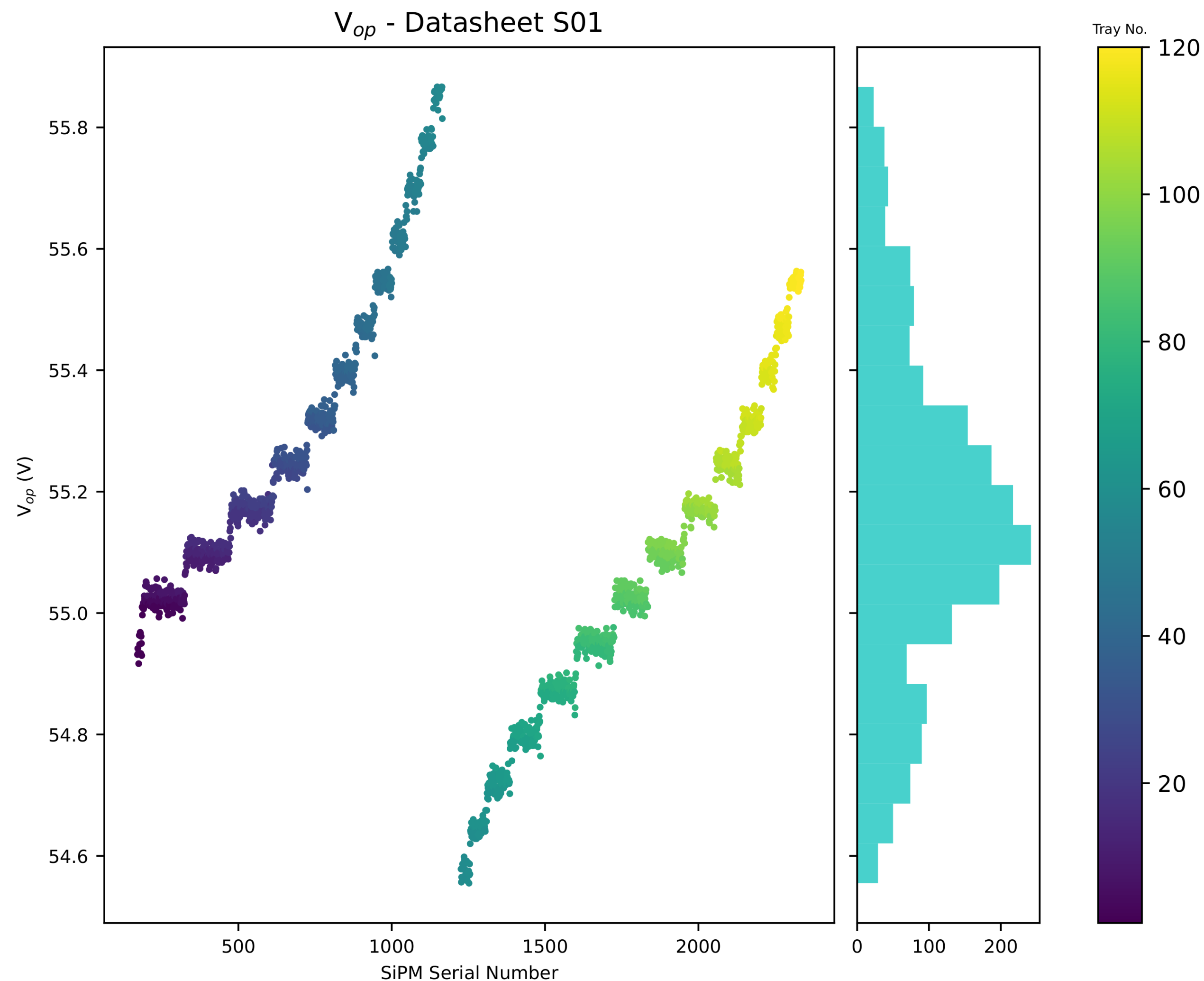


1st HPK production lot



- HPK delivered the first production lot (“Spain”) in 2023-2024;
- Total of 98700 sensors (~16k arrays);
- Total sensor area covered ~ 3.6m²;
- Splitted in 10 deliveries, divided in trays;
- HPK provided us Voltage of operation $V_{op} = V_{bd} + 3V$ for each sensor;
- Breakdown voltage total range ~ 2.4V;
- Batches shared among test sites;

Results: data from HPK

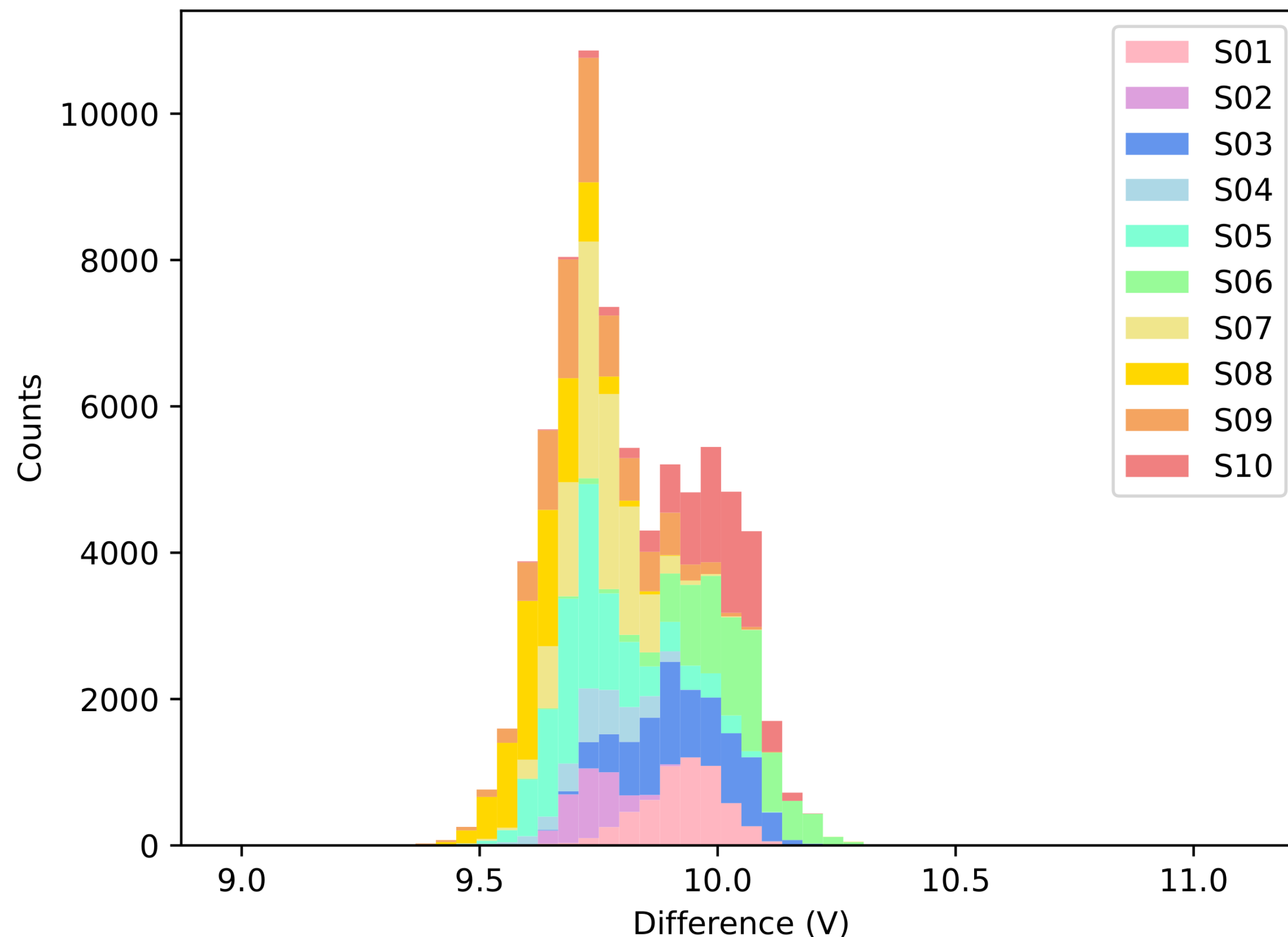


- Example of the 1st delivery;
- Behavior related to manufacturing processes;
- Trays are pre-grouped by the vendor considering similar breakdown voltage values (within 200mV);
- Not continuous serial number.

Results: SiPM check



Voltage difference HPK-CACTUS - All SiPM

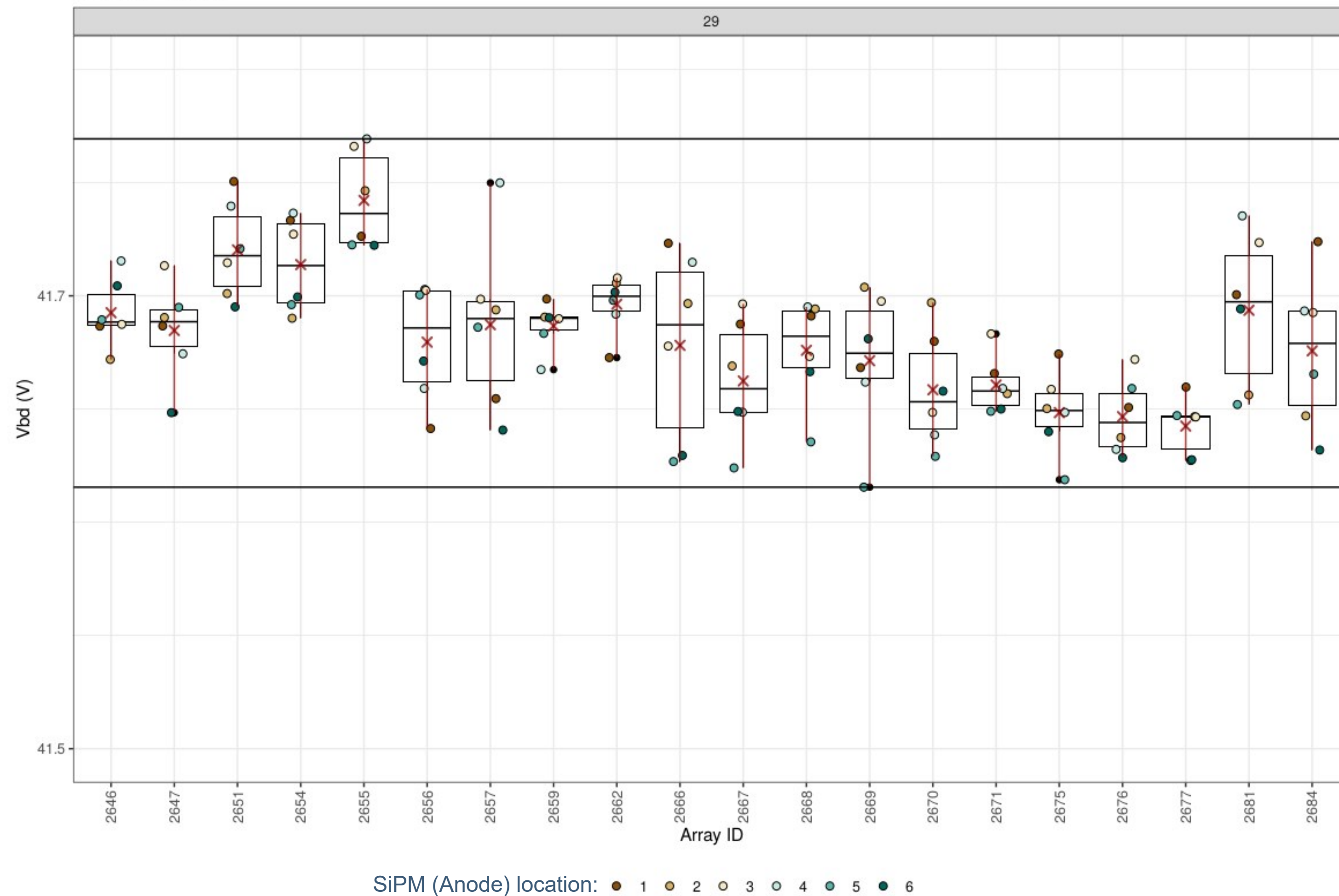


- Compatibility with vendor data at room temperature has been checked using data of breakdown voltage measured at LN2 (to maintain temperature constant) by CACTUS at the 1st thermal cycle;
- Difference centered at $\sim 10\text{V}$ because of the thermal coefficient of the breakdown voltage for these sensors $\sim 43\text{mV/K}$;
- Good results, maximum discrepancy of 0.3V .

Results: V_{bd} @LN2



Vbd spreads in Tray 29 - LN2, Cycle 3
@Ferrara - 2023/07

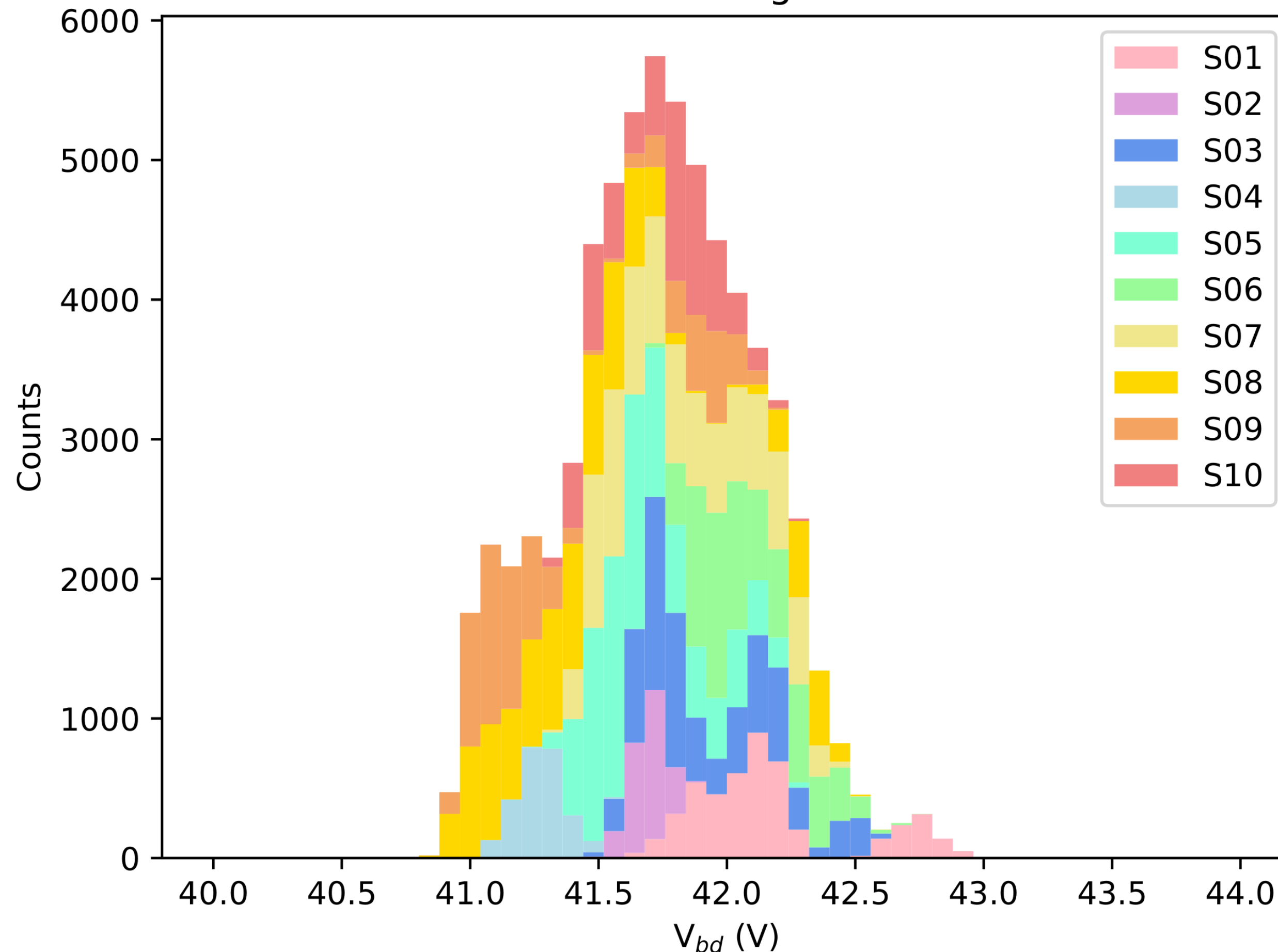


- Example of breakdown voltage measured by CACTUS for a tray (20 arrays of 6 SiPMs each) @LN2;
- Pre-grouped by HPK;
- Min-Max < 200mV .

Results: V_{bd} @LN2



Breakdown voltage - All SiPM

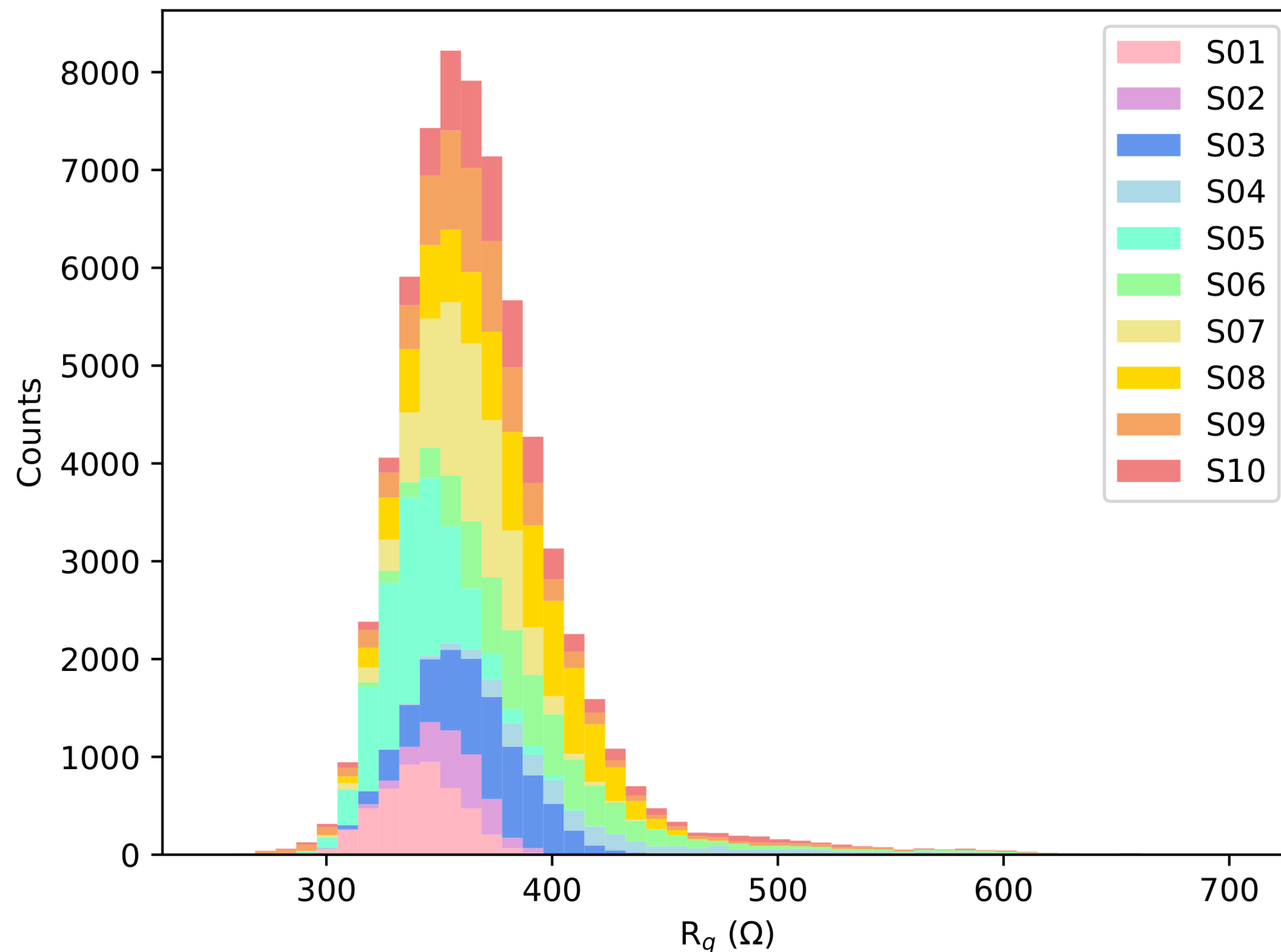


- Breakdown voltage distribution at LN2 3rd thermal cycle;
- 2V total width;
- Behaviour as expected looking at HPK data (~ 2V spread)
- SiPMs are in specs;
- Accordance with thermal coefficient (~ 43mV/K).

Results: R_q @LN2



Quenching resistor - All SiPM

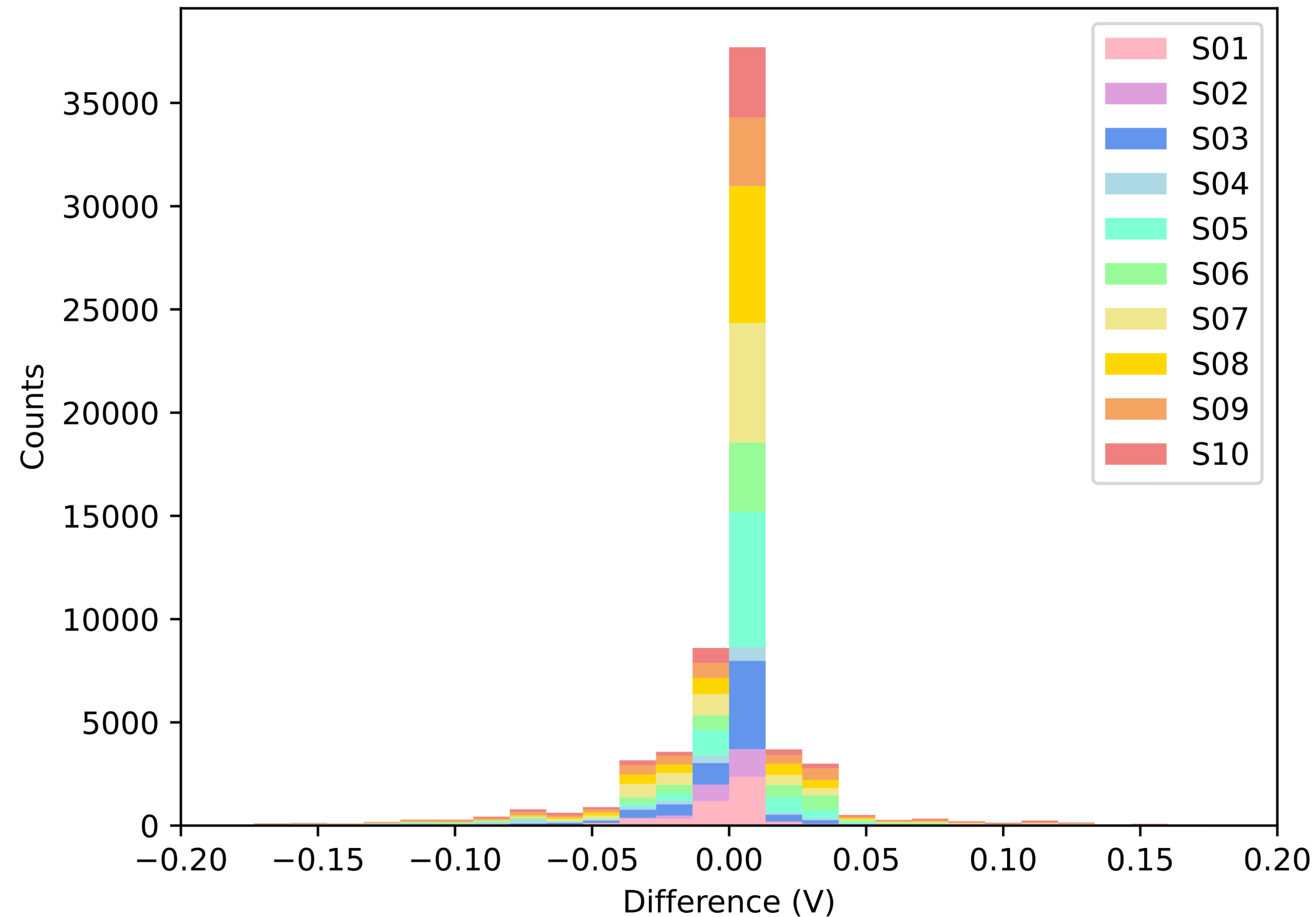


- Quenching resistor distribution at LN2 3rd cycle ;
- Behavior as expected from vendor;
- SiPMs in specs;
- Mean value @LN2 $\sim 358\Omega$ (recovery time $<1000\text{ns}$);
- Accordance with thermal coefficient ($\sim 1\Omega/\text{K}$);
- STD deviation of distribution @LN2 $<50\Omega$.

Results: thermal cycles



Breakdown voltage difference - 3rd-1st - All SiPM

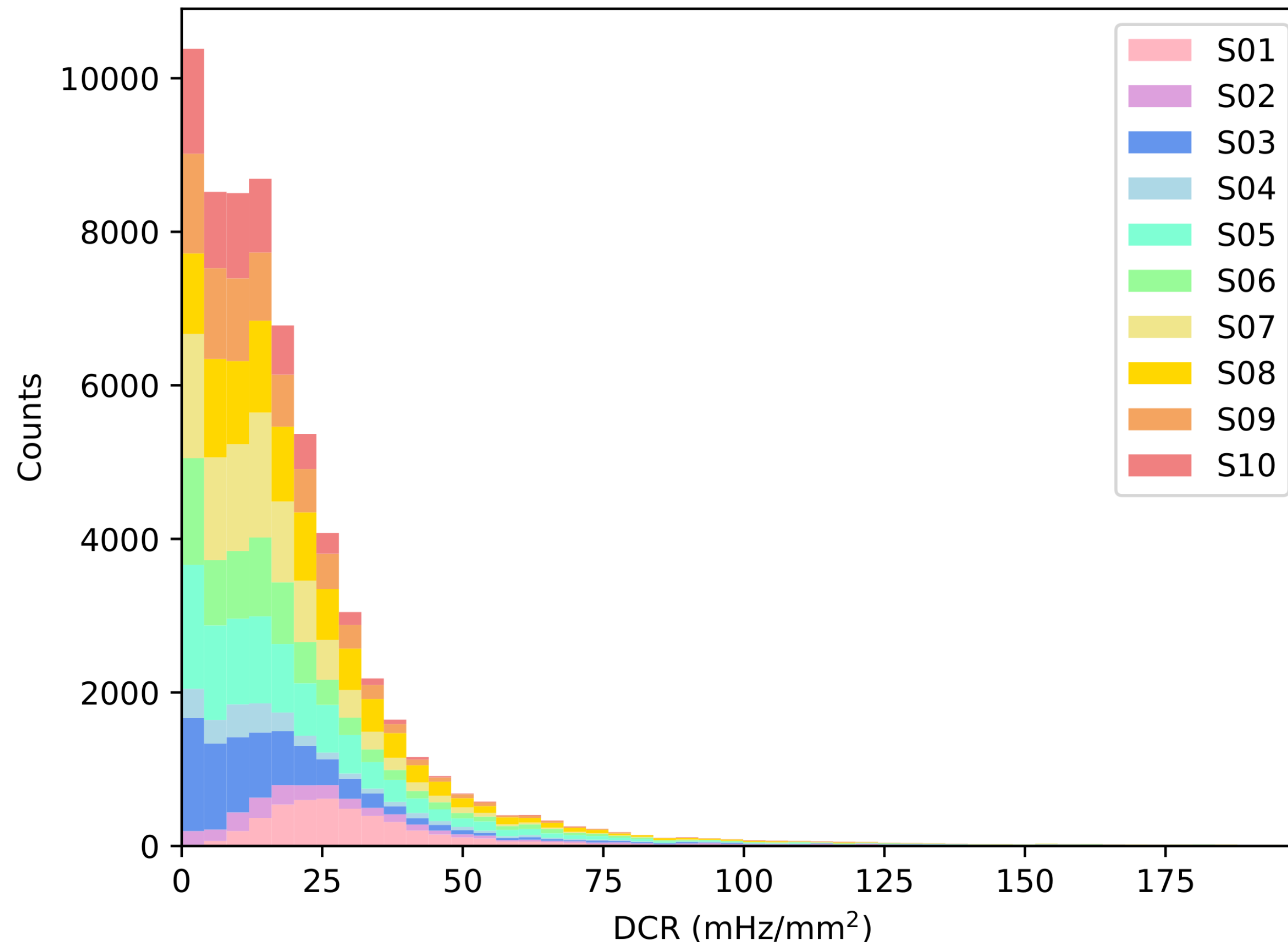


- Resilience to thermal stresses has been checked looking at data at the 1st and at the 3rd thermal cycle;
- Distribution of the discrepancies between the breakdown voltage measured at 3rd and at 1st thermal cycle center at 0V;
- V_{bd} Data within errors (50mV).

Results: DCR @LN2



Dark Count Rate - All SiPM



- Distribution of the DCR measured at LN2 in a time window of 120s in a complete dark environment;
- Considering all dark signals (primary, cross talk, afterpulses, bursts);
- Few dark counts are dominant;
- Almost all SiPMs below 200mHz/mm²
- 48 failed sensors with a very high DCR (>1kHz/mm²), rejected;
- Failed SiPM re-tested at Valencia laboratory.

Bursts: JINST 16 (2021) T10006

Conclusions



- DUNE SiPMs 300k sensors FD1 (+ProtoDUNE HD ~10k sensors);
- CACTUS setup: quality assurance and massive tests;
- System capability: 120 SiPM per single run;
- Tests:
 - IV forward + reverse @ Room Temp;
 - IV forward + reverse @ LN2 Temp before and after thermal stresses;
 - Global DCR;
- Sites: Ferrara, Bologna, Granada, Milano Bicocca, Prague ~2400SiPM/month;
- Tested 95% of the sensors of 1st HPK production lot (94000 SiPMs) with very good results;
- Failure rate until now ~0.05% at single SiPM level;
- 2024-2025 complete tests on all SiPM (HPK + FBK) for FD HD1 with CACTUS.

Thank You

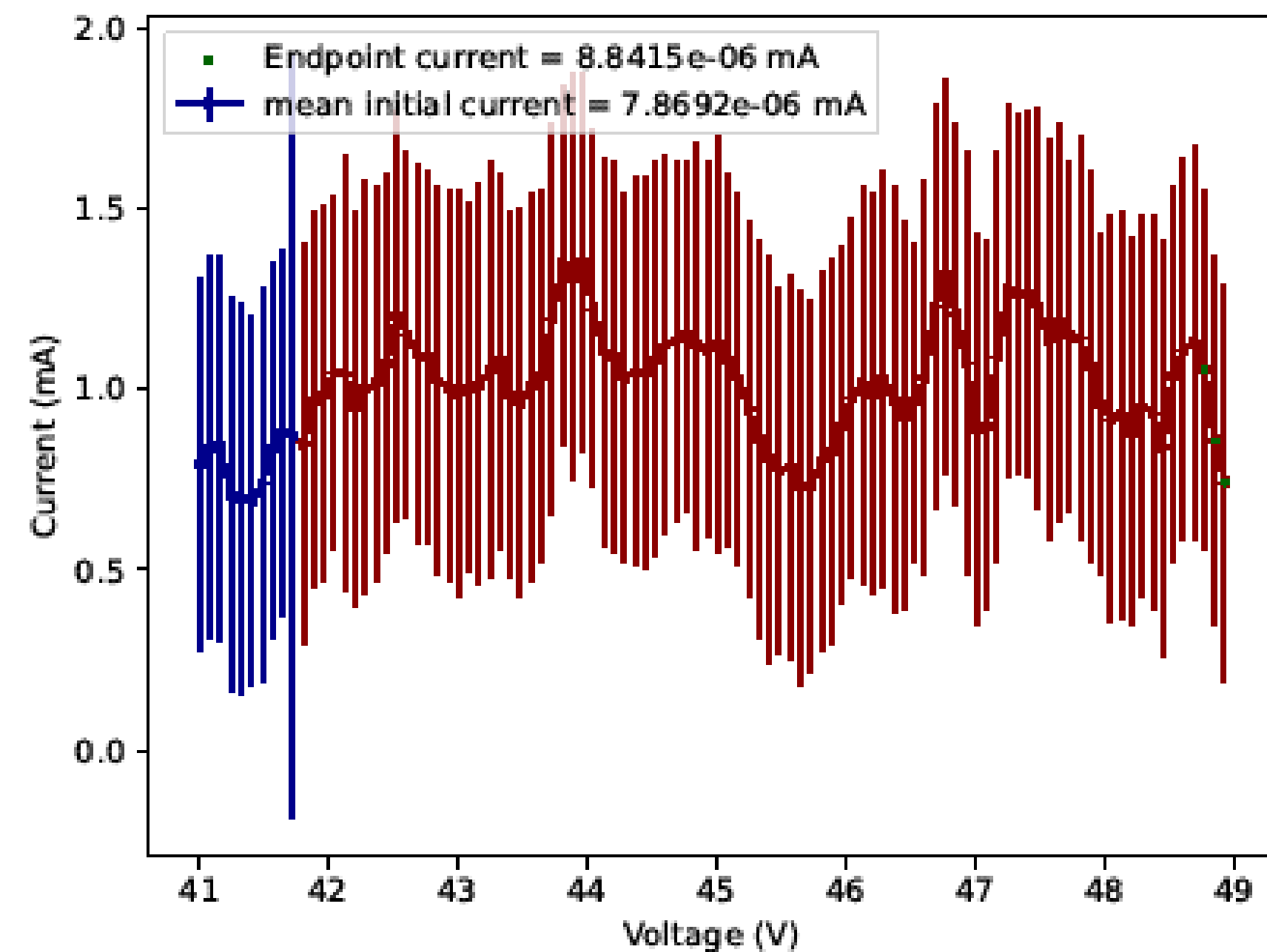
Backup slides

Extended IV curve

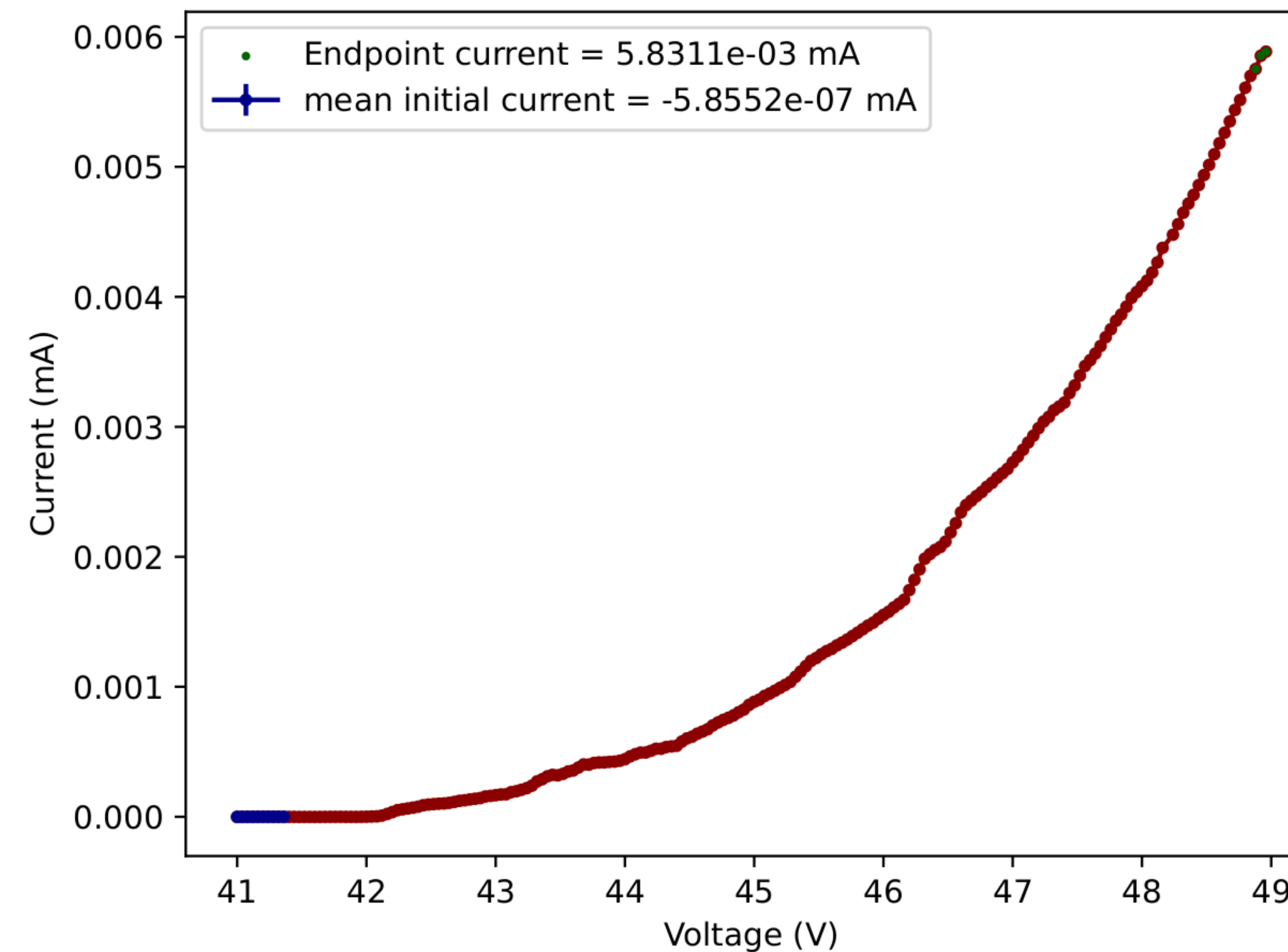
An alternative way to check for DCR is to perform a IV reverse curve in complete dark environment.

For normal SiPM (low dark counts) current is under a measurable threshold while for failed SiPM with very high DCR we can measure a DC current

- Extended IV for normal SiPM



- Extended IV for SiPM with high DCR

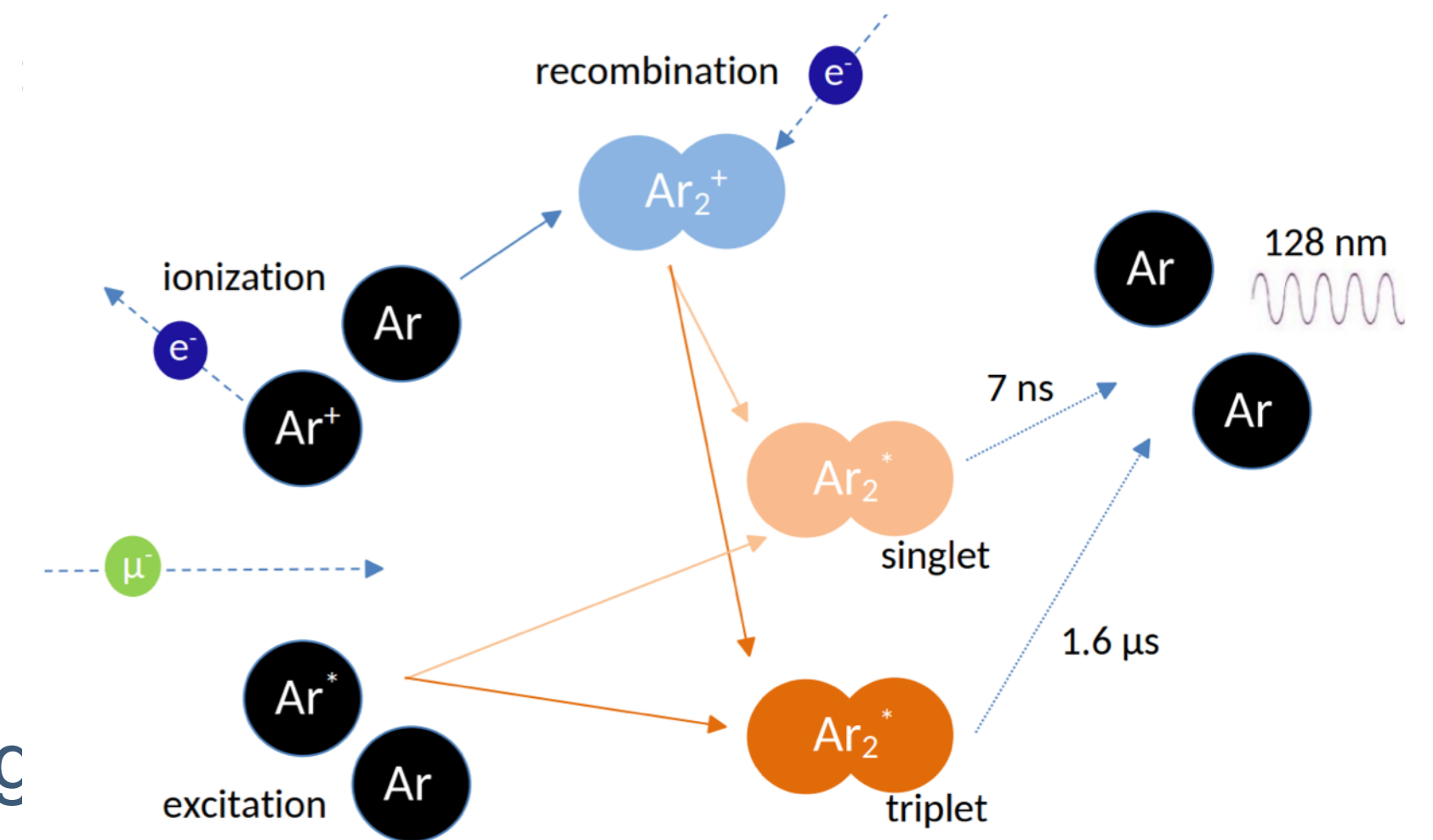


LAr VUV Light Detection

- Excited argon interacts creating excited molecules in singlet and triplet states

- LAr VUV scintillation light ($\lambda = 128 \text{ nm}$) is

- Abundant (25k photons/MeV @ 500 V/cm)
→ enhance calorimetry, especially at low E
- Fast (fast component has $\tau = 7 \text{ ns}$)
→ provides event t_0 , crucial for triggering non-beam events
- Topological
→ Slow/Fast component relative contribution has PID and backg



- Detection of light in DUNE LArTPC

- VUV photons converted to longer wavelength by photofluorescent compounds (WLS)
- Visible light is trapped inside a module and a fraction of it is conveyed to photosensors (SiPMs)